


<b>Search Notes</b>  	<b>Application/Control No.</b>  10517925	<b>Applicant(s)/Patent Under Reexamination</b>  IMMINK ET AL.
	<b>Examiner</b>  Heyi, Henok G	<b>Art Unit</b>  2609

SEARCHED			
Class	Subclass	Date	Examiner
369	13.05	08/01/2007	Henok Heyi
	13.01	03/11/08	Henok Heyi
	47.12	03/11/08	Henok Heyi

SEARCH NOTES		
Search Notes	Date	Examiner
I did a class search and relied on the international search report (ISR)	08/01/2007	Henok Heyi
Updated search.	03/11/08	Henok Heyi

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner